

## APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL

Page 1

Appl. No.

314E

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Component Title: Resistors, Fixed, Chip, Thick Film, based on type CHPHR and CHPFR

Executive Member: C

CNES Date: 27/07/2021

Components (including series and families) submitted for Extension of Qualification Approval:

	-													
ESCC COMPONENT NO.	ESCC COMPONENT VARIANTS NO.			F COMPC	NENTS	B	ASED ON		TEST VEHICLE / S PERIODIC TESTING	COMPONEN SIMILAR	Т			
4001/026 01 & 06 - - 02 & 07 03 & 08			All values 50V to 500V		CHPHR0603 - - CHPHR0805 CHPHR1206			4001026062052F4 4001026015R60G6 4001026011004G6 4001026025621F4 4001026034701G4 4001026031003F4						
04 & 09 05 & 10						CHPHF CHPHF	R2010 R2512		4001026041R50G6 4001026051R20G4 40010260510R0F4 40010260536R5F4					
11 & 16 12 & 17 13 & 18						CHPFF CHPFF CHPFF	R0603 R0805 R1206		- 4001026122003F4 4001026131R00G4	See also box 14 fo Failure Rate endu test vehicles	or rance			
	14 & 19 15 & 20					CHPFF CHPFF	R2010 R2512		4001026141004G6					
Component Ma	anufacturer	2	Location	of Manufa	cturing Plant	(s)	3			·	4			
VISHAY SA Division SFERNICE			199 Bld de la Madeleine BP 1159 06003 NICE CEDEX 1 - France			Date of original qualification approval: Date: 11/10/2011								
								Certif	icate Ref No.					
		5					6	314			7			
ESCC Specifications	used for	5	Deviations to LVT testing and Detail Specification			Qualification Extension Report			1					
Maintenance of qualit	fication testing:		used:			reterence and date: Report CAZ/21.001, July 2021								
Generic. 4001	issue. J					Керо	TCA2/21.001, July 202							
Detail(s): 4001026 Issue: 7			Deviation from current Specifications:											
			No 🛛 Y	es 🗌	(Supply o	letails)								
								1			8			
Summary of procurer	<u>nent or equivalent t</u>	est re	sults during curr	rent validit	y period in su	pport of t	his ap	plicatio	n (those to ESCC listed fi	rst)				
Project Name	Testing Le	vel	LAI Date code			le		Quantity	y Delivered					
See report CAZ/21.00	J1 -		None						Total ≈ 55 000 with CF CH	IP HR ≈ 44 000 IP FR ≈ 11 000				
VISHAY Dale THALES DMS														
ALTER Tech. TTI Inc.														
ECOMAL ARROW														
PID changes since st	art of qualification			9 C	urrent PID V	erified by	':		JP Bussenot, CN	NES	10			
None 🗆			-					N	ame of Excutive Represe	ntative Agency				
Minor* 🛛				R	ef No:	PID CHP	HR FF	۲						
Major* 🛛	*Provide details in	box:		Is	sue: 8 ev Date: 2	3 23/07/202	1		Date:	27/07/2021				
I						0/01/202					11			
Current Manufacturing facilities surveyed by:			ESA and CNES				on 07/02/2019							
		(Name of	Executive Re	presenta	tive Ag	gencies	)	(Date)						
Satisfactory:	Yes 🛛		No 🗆	Explain	l									
Report Reference:	CNES DCT/ 2019/000332	/AQ/0 5, 15/	CQ- 02/2019	_			CNES DCT/AQ/CQ- Report Reference: 2019/0003325, 15/02/2019							

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL							
<b>ESCC</b>	Component title:	Resistors, Fixed,	Chip, Thick Film, based on ty	pe CHPHR and CHPFR	Appl. No.		
	Executive Member:	CNES	Date:	27/07/2021	314E		
Failure Analysis, DPA, NCCS av	ailable: Yes	🛛 No 🗆			12		
Ref. No's and purposes: Vishay SA manufactu	CAR12005 – NC clos ring lot)	ed. See box 22. (CH	PHR0603L49R9GBW (0603	49.90hm) DC1346 and 18	323 -unique		
The undersigned hereby certifies on behal that the appropriate documentation has be (except as stated in box 15;) - that the rep CNES as the responsible Executive Mem	f of the ESCC Executi een evaluated; - that fu orts and data are avail ber for ESCC qualifica	ve - that the above in III compliance to all E able at the ESCC E ation status to be ext	nformation is correct; - ESCC requirements is eviden kecutive and therefore applie kended to the component(s) I	ce s on behalf of sted herein.	13		
Date: 29/07/2021				JP. BUSSENO	r		
			(S	ignature of the Executive C	Coordinator)		
Continuation of Boxes above:					14		
Report 20 45 104, 0 Failure Rate Endurance Testing subgrou 15 test vehicles (8 000 hours completed CHPFR0603, 110 – 2,15k – 750k CHPFR1206, 27 – 30k – 200k CHPFR2010, 50 – 15k – 221k CHPFR2512, 68 – 27k – 475k 30 parts for each lot. Failure Rate Endurance Testing subgrou 2 test vehicles (6 000 hours performed); CHPFR2512 4,3 – 20k 30 parts for each lot. Failure Rate Endurance Testing subgrou 12 test vehicles (4 000 hours performed CHPFR0603, 22 – 20k – 1M CHPFR0603, 22 – 20k – 1M CHPFR0603, 22 – 30k – 200k CHPFR2100, 8,25 – 39k – 5,11M 30 parts for each lot. Failure Rate Endurance Testing subgrou 0 test vehicles (2 000 hours performed); None 0 part for each lot FR report 20 45 104 is appended to report	2/11/2020 Ip of Chart F4 perform Ip of Chart F4 perform Ip of Chart F4 perform Ip of Chart F4 perform CAZ/21.001	ed on ed on ed on					

	APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL						
and a	ESCC	Component	title: Resistors, Fixed, Chip, Thick Fi	ilm, based or	type CHPHR and CHPFR	Appl. No.	
T-mp		Executive N	lember: CNES	Date	e: 27/07/2021	314E	
Non com	nliance to ESCC requirements:	I				15	
No	Specification		Dorograph		Non compliance		
NO	Specification		Falayiapii		Non compliance		
Additiona	l tasks required to achieve full co	mpliance for F	SCC qualification or rationale for accent	ability of			
noncomp	liance:					16	
Executive	e Manager Disposition					17	
Applicatio	on Approval: Yes 🗷	No 🗆					
Action / R	Remarks:						
				-			
				B		signed Schade	
Date:				S	chade Date: 20 10:59:37	21.08.31 ' +02'00'	
				В.	Schade: Head of the Produc and Safety Department	t Assurance	

				APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL							
	and the second	ESCC	Comp	onent	Title: Resistors, Fix	ed on type C	HPHR and CHPFR	Appl. No.			
100	Calls -		Execu	utive M	e: 27/07/2021	314E					
AN	NEX 1: LIS	T OF TESTS DONE TO S	UPPORT	EXTE	NSION OF QUALIFICA	TION				18	
Те	sts conducte	ed in compliance with:									
	- ES	CC 4001 generic specific	ation; Cha	rt F4							
Tests vehicle identification/description:											
	1001026062	05254 20 5KOhm DO 10	00000		400402642200254		2001 (0805				
4001026062052F4 20,5KOhm DC 1938 4001026015R60G6 5.6Ohm DC 2037 (0 4001026011004G6 1MOhm DC 2037 (0				Jobs 4001026122003F4 200KOhm DC 2001 (0805, FK)   i03) 4001026034701G4 4,7KOhm DC 1937 (1206)   03) 4001026131R00G4 10hm DC 2018 (1206)   0805) 4001026031003F4 100KOhm DC 2041 (1206)							
	001020020	004G6 1MOhm DC 2003	(2010, FR	1005) 4001026031003r4 100KOnm DC 2041 (1206) 10. FR) 4001026051R2064 1.20hm DC 1912 (2512)							
4	001026041	R50G6 1,5 Ohm DC 1918	3 (2010)		40010260510R0F4	36.50hm DC 20	2019 (2512) 2019 (2512)				
De	tail Specifica	ation reference:	4001/026								
			Tick				Tested	N° of	Comments if not	performed	
	Chart F4	Test	when done		Conditions	Date Code	Qty	Rejects	Comments on F	Rejection	
		Mounting	$\boxtimes$	IEC 6	60115-1 clause 4.31	All	2 x 3 11 x 5	0			
		Rapid Change Of Temperature	$\boxtimes$	IEC 6	60068-2-14	All	2 x 3 11 x 5	0			
		Vibration		IEC 6	60068-2-6				NA		
		Climatic test Sequence	$\boxtimes$	ESC	C 4001, Para 8.10	All	2 x 3 11 x 5	0			
		Seal Test		IEC 6	60068-2-17				NA		
		Mounting	$\boxtimes$	IEC 6	60115-1 clause 4.31	All	2 x 3 11 x 2	0			
	dno.	Robustness of Terminations	$\boxtimes$	IEC 6	60068-2-21	All	2 x 3 11 x 2	0			
	Environmental /Mechanical Subgro	Climatic test Sequence	$\boxtimes$	ESC	C 4001, Para 8.10	All	2 x 3 11 x 5	0			
		Seal Test		IEC 6	60068-2-17				NA		
		Resistance to Soldering Heat	$\boxtimes$	IEC 6	60068-2-20	All	2 x 3 11 x 2	0	Parts are not mounted was agreed not to inclu Climatic Sequence (PI	, therefore it ude them in D before 2020)	
		Mounting	$\boxtimes$	IEC 6	60115-1 clause 4.31		11 x 2		NA per agreement (PII	D before 2020)	
		Climatic test Sequence		ESC	C 4001, Para 8.10		11 x 2	0	NA per agreement (PII	D before 2020)	
		Seal Test		IEC 6	60068-2-17				NA		
		Mounting		IEC 6	60115-1 clause 4.31				NA		
		Insulation Resistance		ESC	C 4001, Para 8.3.1.2	1918 1912 1938 1938 1937 2001 2003 2011 2019 2018	13 x 5	0			
		Voltage Proof		ESC	C 4001, Para 8.3.1.3	1918 1912 1938 1938 1937 2001 2003 2011 2019 2018	13 x 5	0			
	up	Mounting		IEC 6	60115-1 clause 4.31						
	nduraı ubgro	Operating Life		ESC	C 4001, Para 8.13		-	-	Replaced with FR data testing (See below and	i in periodic I box 14)	
	ΠN	Seal Test		IEC 6	60068-2-17				NA		
	Assembly Capability Subgroup	Solderability	$\boxtimes$	IEC 6	60068-2-20	All	13 x 2	0			
		Permanence of marking		ESC	C 24800				NA		
	ilure ate group	Operating Life 8 000 h		ESC	C 4001, Para 8.13	29 lots	29 x 30	0	5,40 M components	s.hours	
	Fail Ra Subg	Seal Test		IEC 6	60068-2-17				NA		
	Additional Tests	Temperature Coefficient		ESC	C 4001, Para 8.3.3	All	13 x 5	0	Lot DC 1912: One repe at the 1,02Rn = 1,224	eatable value Ohm limit	

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ES	<b>SCC</b>	Component title:	Resistors, Fixed	Chip, Thick Film, based on t	ype CHPHR and CHPFR	Appl. No.			
		Executive Member:	CNES	Date:	27/07/2021	314E			
NOTE	S ON THE COMPL	ETION OF THE APPI	LICATION FORM	FOR ESCC QUALIFICATIO	N EXTENSION APPROVA	L			
ENTRIES Form heading	shall indicate: - th Member; - the ent	ne title of the compor ering date; - the certifi	nent as given in it icate number and i	s detail specification or the t ts sequential suffix.	name of the series, family	; - the Executive			
Box 1	shall provide deta components (the designation given characteristic capa if relevant.	ails given in the table ESCC code is recon in the detail specifi able of identifying the	e; in particular the mmended to indic cation as 'base o component tested	ere shall be listed: - the val ate the values or values ra on'; - under Test Vehicle er (e.g., voltage of coil for a rela	iants or range of variants ange, the tolerance, the v nter either an ESCC code ay); - under component sim	; - the range of oltage, etc); the e or the specific ilar enter a cross			
Box 2; 3 and 4 As per QPL entry; otherwise, an explanation of the changes must be supplied.									
Box 5	<b>Box 5</b> Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the terreported were performed. If the specifications are different from those current on the date of the application, see Box 6.								
Box 6	Will show the devi deviations this mu revision indicate a	ations from the Gene ust be listed in Box 1 lso whether the test d	ric and Detail Spe 15. In case the re ata deviates or no	cifications listed in Box 5, in ferenced specification in Bo t from such current document	particular deviations from te x 5 have currently a differ s.	esting. In case of ent issue and/or			
Box 7	Must reference the	e report(s) supplied in	support of the app	lication.					
Box 8	Should provide th delivered to the E this box.	e details of procuren SCC Executive under	nent to the full ES r the terms of the	SCC System, documentation relevant Generic Specification	of all of which should alr n. An appropriate table ha	eady have been is been drawn in			
Box 9	If the PID evolved shall be provided to	d after the Original Qu together with the reas	ualification or afte ons for the change	r the last Extension of Quali s. Major changes shall be cle	fication, adequate details c early marked.	of such evolution			
Box 10	Identify the currer arranged as close	nt PID issue status, d as possible to the rec	late and actual da quired date of exte	te of verification. The date on sion.	of verification of the currer	nt PID should be			
Box 11	This box can be of practices, procedu carried out in acco	completed only after a ures, material, etc. us ordance with the requi	a physical visit to sed in manufactur rements of ESCC	the plant to confirm that no using the components are as Basic Specification No. 2020	nexplained changes occur described in the PID. This ) and its findings shall be re	rred and that the survey shall be ecorded.			
Box 12	Provide details o Nonconformance( satisfactory results	f, or reference to, a s) (NCCS) occurred d s.	ny Destructive P luring the qualifica	hysical Analysis (DPA) and tion validity period, stating if e	Failure Analysis reports established corrective actio	as well as any n have produced			
Box 13	Enter only the na Coordinator.	me of the Executive	Member (i.e., CN	ES, DLR, ESTEC, etc.) and	the signature of the respo	nsible Executive			
Box 14	To be used when the relevant Box. I	there is a need to exp Box 14 can be broken	oand any of the bo into 14a, 14b, etc	xes from 1 through 12. Identi . if several boxes have to be (	fy box affected and referer expanded.	ice the Box 14 in			
Box 15	Fill in Table as rec	juested.							
Box 16	Any additional act by the ESCC Exec	ion deemed necessar cutive should be listed	y by the Executive I herein or the reas	e Member to bring the submit on(s) to accept the noncomp	ted data to a standard likel liance.	y to be accepted			
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.								
Box 18	Fill in Table as rec	uested.							
Box 19	Confidential Detai	ls of PID changes incl	uding those of a c	onfidential nature, shall be pr	ovided.				
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.								
Box 21	Any additional act by the ESCC Exec	ion deemed necessar cutive should be listed	y by the Executive I herein or the reas	e Member to bring the submit on(s) to accept the noncomp	ted data to a standard likel liance.	y to be accepted			
Box 22	Box 22 Additional Comments.								